

Activity classification for real-time wearable systems : effect of window length, sampling frequency and number of features on classifier performance

Allik, Ardo; Pilt, Kristjan; Karai, Deniss; Fridolin, Ivo; Leier, Mairo; Jervan, Gert 2016 IEEE EMBS Conference on Biomedical Engineering and Sciences (IECBES) : Kuala Lumpur, 4-8 December 2016 / p. 460-464 : ill
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Advancing novel physical fatigue assessment and human activity monitoring methods towards personalized feedback with wearable sensors = Kantavatel seadmetel põhinevate füüsilise väsimuse hindamise ning inimese aktiivsuse monitoorimise meetodite arendamine personaalseks tagasisideks

Allik, Ardo 2022 <https://doi.org/10.23658/taltech.62/2022> <https://digikogu.taltech.ee/et/Item/230f302e-0cf1-4b86-a9d3-0927a51b36e2>
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Automated minimization of concurrent online checkers for network-on-chips

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